20N40K-MT Preliminary Power MOSFET

# 20A, 400V N-CHANNEL POWER MOSFET

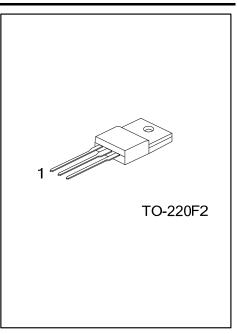
#### **■** DESCRIPTION

The UTC **20N40K-MT** is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

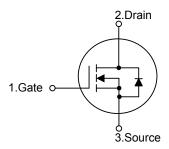
The UTC **20N40K-MT** is generally applied in high efficiency switch mode power supplies.



<sup>\*</sup>  $R_{DS(ON)}$  < 0.22 $\Omega$  @  $V_{GS}$  = 10V,  $I_{D}$  = 10A



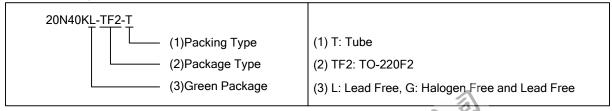
#### ■ SYMBOL



#### **■ ORDERING INFORMATION**

Ordering	Doolsons	Pin	Dealine			
Lead Free	Halogen Free	Package	1	2	3	Packing
20N40KL-TF2-T	20N40KG-TF2-T	TO-220F2	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source



#### **■ MARKING**



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<sup>\*</sup> High Switching Speed

## ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{ extsf{DSS}}$	400	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Drain Current	Continuous	T <sub>C</sub> =25°C	I <sub>D</sub>	20	Α
	Pulsed (Note 2)		I <sub>DM</sub>	80	Α
Avalanche Current (Note 2)		I <sub>AR</sub>	20	Α	
Avalanche Energy Single Pulsed (Note 3)		E <sub>AS</sub>	1000	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation (T <sub>C</sub> =25°C)		D	45	W	
Derate above 25°C		$P_D$	0.35	W/°C	
Junction Temperature		$T_J$	+150	°C	
Storage Temperature		$T_{STG}$	-55~+150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 5.01mH,  $I_{AS}$  = 20A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C
- 4.  $I_{SD} \le 20A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$

#### **■ THERMAL DATA**

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	62.5	°C/W	
Junction to Case	$\theta_{JC}$	2.8	°C/W	

#### ■ ELECTRICAL CHARACTERISTICS

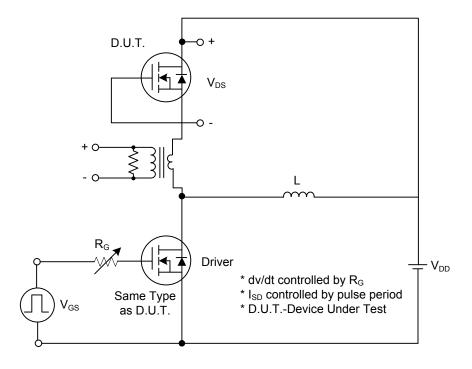
PARAMETER		SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		$BV_{DSS}$	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	400			V	
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS}/\triangle T_{J}$	Reference to 25°C, I <sub>D</sub> =250µA		0.5		V/°C	
Drain-Source Leakage Current		$I_{DSS}$	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V			10	μΑ	
Gate- Source Leakage Current	Forward	loss	V <sub>GS</sub> =+30V, V <sub>DS</sub> =0V			+100	nΑ	
	Reverse	I <sub>GSS</sub>	$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =10A		0.15	0.22	Ω	
DYNAMIC PARAMETERS								
Input Capacitance		C <sub>ISS</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		1170		pF	
Output Capacitance		Coss			300		pF	
Reverse Transfer Capacitance		$C_{RSS}$			11.9		pF	
SWITCHING PARAMETERS								
Turn-ON Delay Time		t <sub>D(ON)</sub>			110		ns	
Rise Time		t <sub>R</sub>	$V_{DS}$ =30V, $I_{D}$ =0.5A, $R_{G}$ =25 $\Omega$		190		ns	
Turn-OFF Delay Time		t <sub>D(OFF)</sub>	(Note 1, 2)		372		ns	
Fall-Time		t <sub>F</sub>			200		ns	
Total Gate Charge at 10V		$Q_{G(TOT)}$	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =1.3A		57		nC	
Gate to Source Charge		$Q_GS$	(Note 1, 2)		15		nC	
Gate to Drain Charge		$Q_GD$	(Note 1, 2)		16		nC	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is	A 177 100			20	Α	
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>	(Pa): Kg			80	Α	
Drain-Source Diode Forward Voltage		V <sub>sD</sub>	$I_{SD}$ =23A, $V_{GS}$ =0V			1.5	V	

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

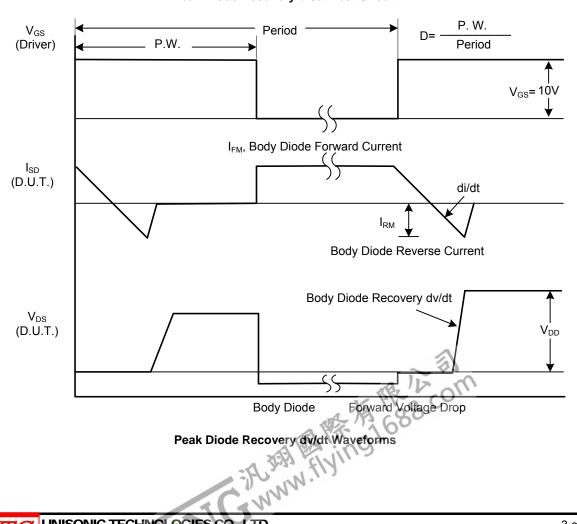
2. Essentially Independent of Operating Temperature Typical Characteristics



#### **TEST CIRCUITS AND WAVEFORMS**

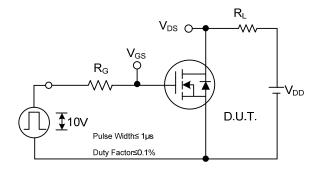


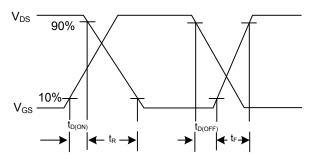
### Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

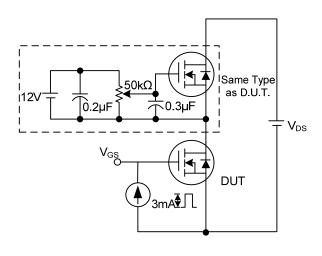
# **TEST CIRCUITS AND WAVEFORMS (Cont.)**

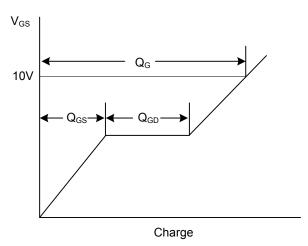




**Switching Test Circuit** 

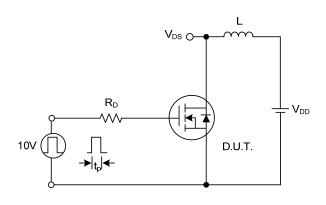
**Switching Waveforms** 

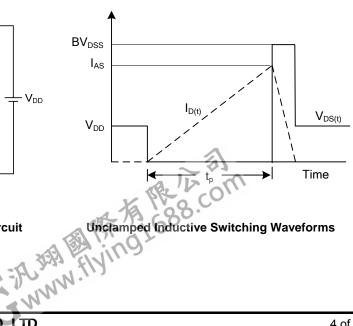




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

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